## Applicant(s)/Patent Under Application/Control No. Reexamination 10/797,226 LIH ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Kevin M. Nguyen 2629 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 315/169.3 US-6,680,580 01-2004 Sung, Chih-Feng Α 345/82 US-6,950,082 09-2005 Sung et al. В 345/90 С US-6,542,142 04-2003 Yumoto et al. 05-2005 Chen et al. 345/82 US-6,891,520 D US-Ε US-F US-G US-Н US-US-J Κ US-

## **FOREIGN PATENT DOCUMENTS**

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## NON-PATENT DOCUMENTS

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